

Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$

Applications

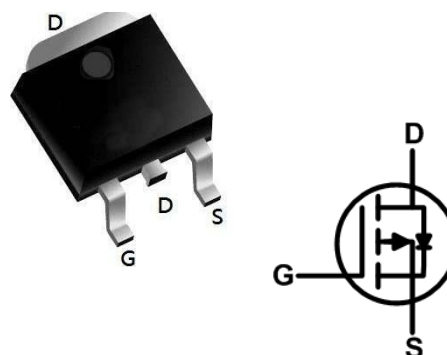
- Battery switching application
- Hard switched and high frequency circuits
- Power management

Product Summary



BVDSS	RDSON	ID
-100V	45mΩ	-30A

TO252 Pin Configuration



Absolute Maximum Ratings:

Symbol	Parameter		Value	Units
V_{DSS}	Drain-to-Source Voltage		-100	V
I_D	Continuous Drain Current	$T_C = 25\text{ }^{\circ}\text{C}$	-30	A
	Continuous Drain Current	$T_C = 100\text{ }^{\circ}\text{C}$	-17.8	A
I_{DM}^{a1}	Pulsed Drain Current		-112	A
E_{AS}^{a2}	Single pulse avalanche energy		225	mJ
I_{AR}	Single pulse avalanche current		30	A
V_{GS}	Gate-to-Source Voltage		± 20	V
P_D	Power Dissipation		83	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range		150, -55 to 150	$^{\circ}\text{C}$
T_L	Maximum Temperature for Soldering		260	$^{\circ}\text{C}$

Thermal Characteristics:

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.5	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	102	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics (TA= 25°C unless otherwise specified):

Static Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-100	--	--	V
I _{DSS}	Drain to Source Leakage Current	V _{DS} =-100V, V _{GS} =0V	--	--	1	μA
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} =-20V, V _{DS} =0V	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} =+20V, V _{DS} =0V	--	--	-100	nA
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA	-1.5	-2.0	-2.5	V
R _{DS(ON)1}	Drain-to-Source Resistance On-	V _{GS} =-10V, I _D =-20A	--	45	55	mΩ
R _{DS(ON)2}	Drain-to-Source Resistance On-	V _{GS} =-4.5V, I _D =-10A	--	55	65	mΩ

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	V _{GS} = 0V V _{DS} = -50V f = 1.0MHz	--	2100	--	pF
C _{oss}	Output Capacitance		--	168	--	
C _{rss}	Reverse Transfer Capacitance		--	26	--	
R _g	Gate resistance	V _{GS} = 0V, V _{DS} Open	--	2.8	--	Ω

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D = -20A V _{DS} = -50V V _{GS} = -10V R _G = 5Ω	--	8.2	--	ns
t _r	Rise Time		--	19.6	--	
t _{d(OFF)}	Turn-Off Delay Time		--	62.8	--	
t _f	Fall Time		--	41.4	--	
Q _g	Total Gate Charge	V _{GS} = -10V V _{DS} = -50V I _D = -20A	--	38	--	nC
Q _{gs}	Gate Source Charge		--	6.4	--	
Q _{gd}	Gate Drain Charge		--	6.8	--	

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
V _{SD}	Diode Forward Voltage	I _S =-20A, V _{GS} =0V	--	--	-1.2	V
t _{rr}	Reverse Recovery time	I _S =-20A, V _{DD} =-50V dI/dt=100A/μs	--	68	--	ns
Q _{rr}	Reverse Recovery Charge		--	200	--	nC

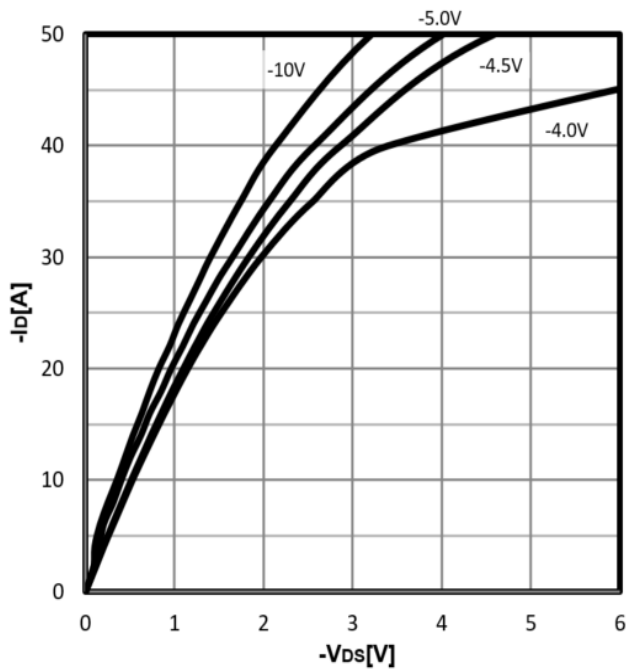
a1: Repetitive rating; pulse width limited by maximum junction temperature

a2: L=0.5mH, R_g=25Ω, Starting T_J=25 °C

Characteristics Curve:

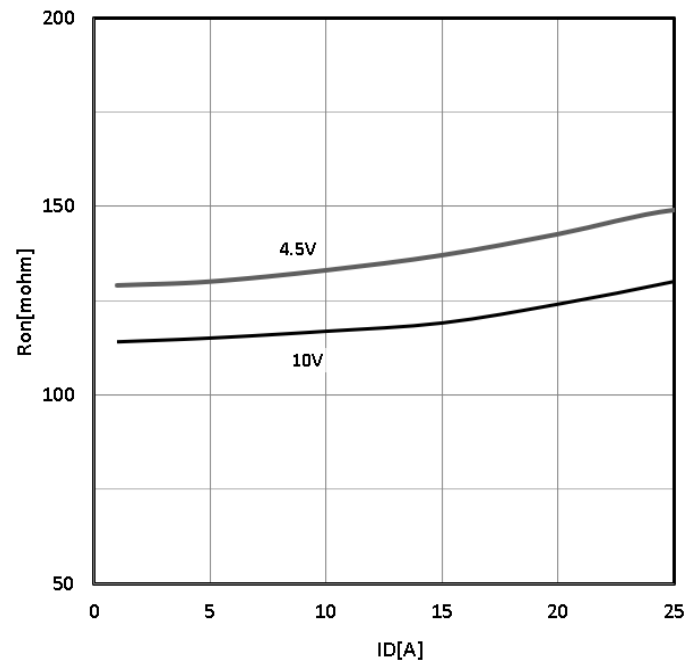
Typ. output characteristics

$$-I_D = f(-V_{DS})$$



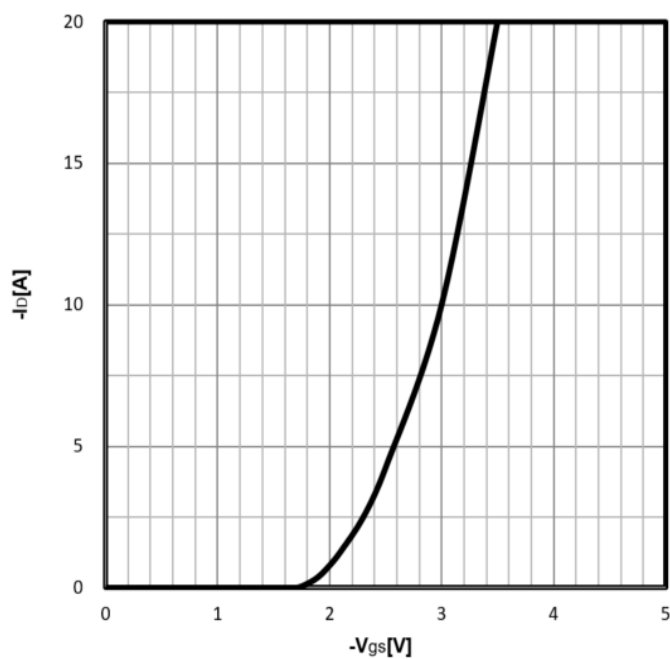
Typ. drain-source on resistance

$$R_{DS(on)} = f(-I_D)$$



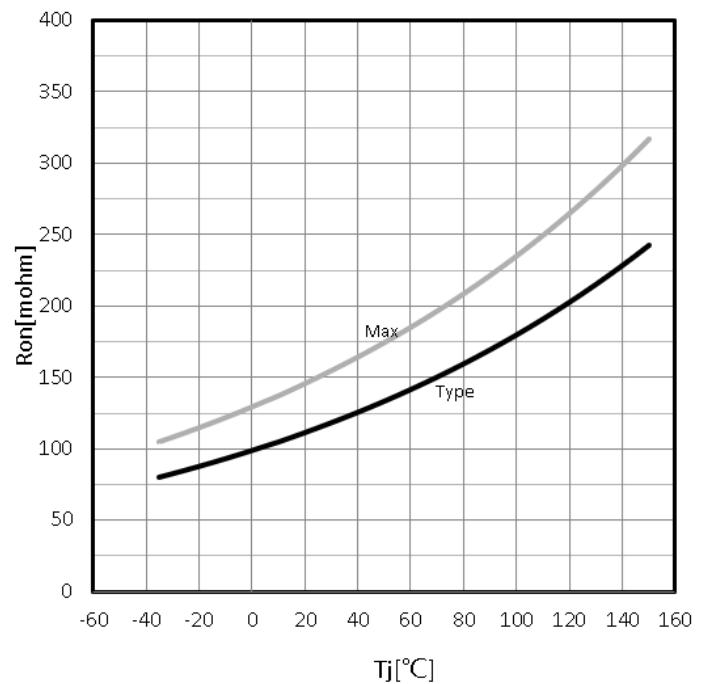
Typ. transfer characteristics

$$-I_D = f(-V_{GS})$$

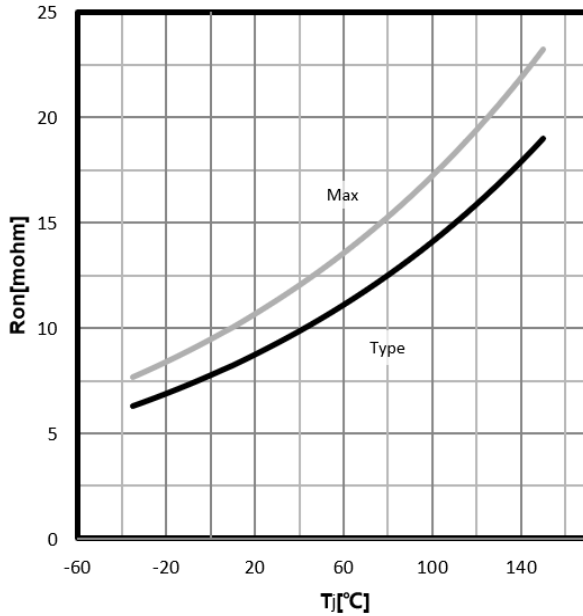


Drain-source on-state resistance

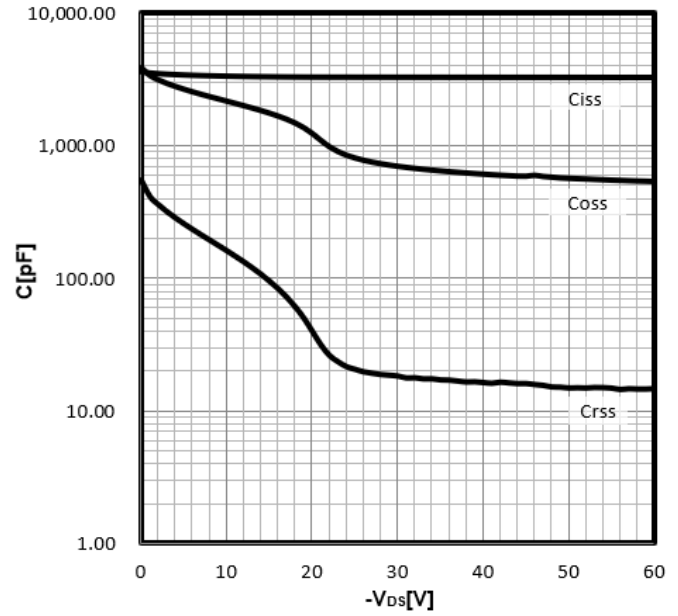
$$R_{DS(on)} = f(T_j); I_D = -5A; V_{GS} = -10V$$



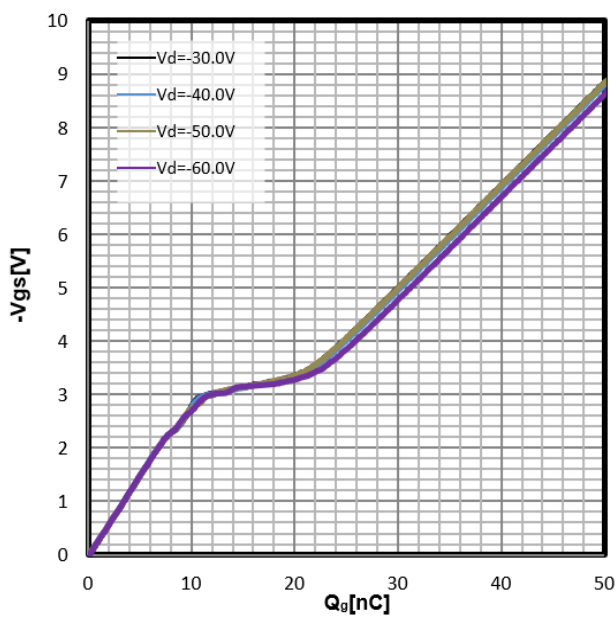
Drain-source on-state resistance
 $R_{DS(on)} = f(T_j); I_D = -20A; V_{GS} = -10V$



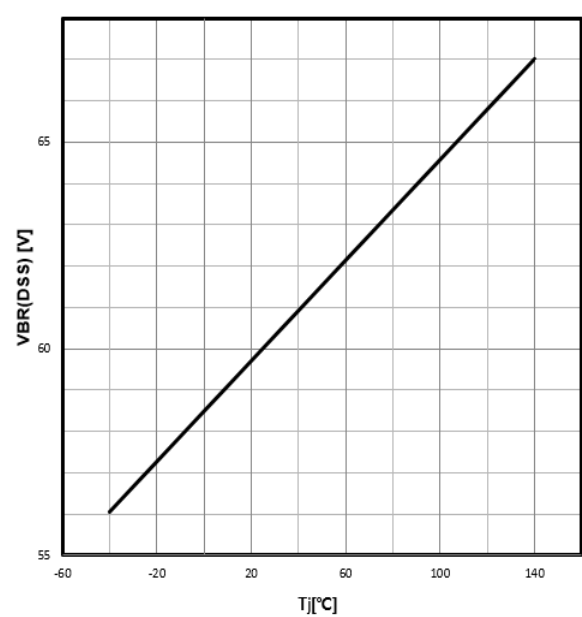
Typ. capacitances
 $C = f(V_{DS}); V_{GS} = 0V; f = 1MHz$



Typ. gate charge
 $V_{GS} = f(Q_{gate}); I_D = -20A$

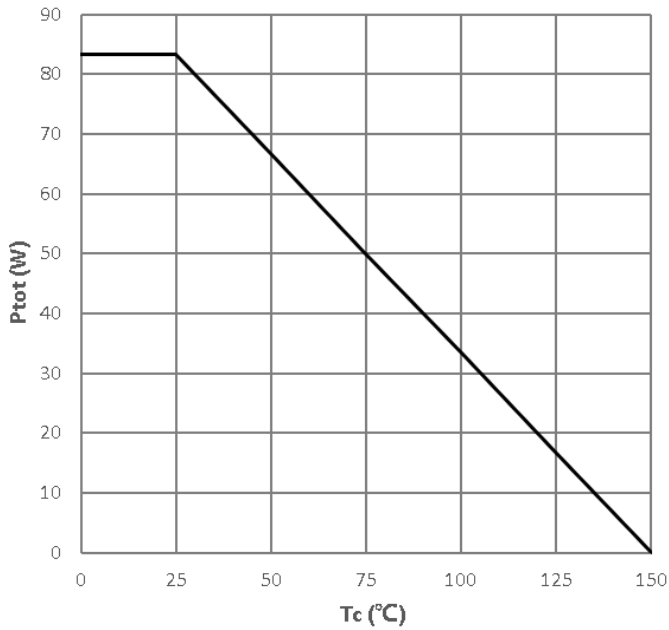


Drain-source breakdown voltage
 $V_{BR(DSS)} = f(T_j); I_D = -250uA$

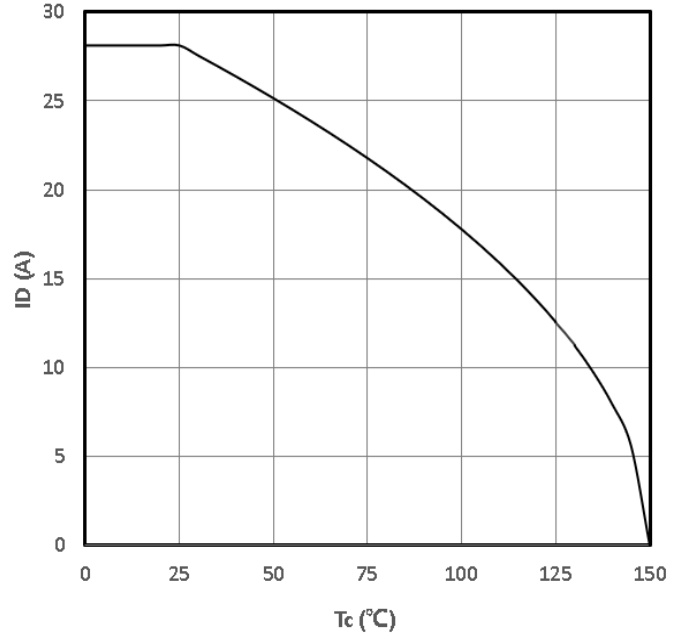


P-Ch 100V Fast Switching MOSFETs

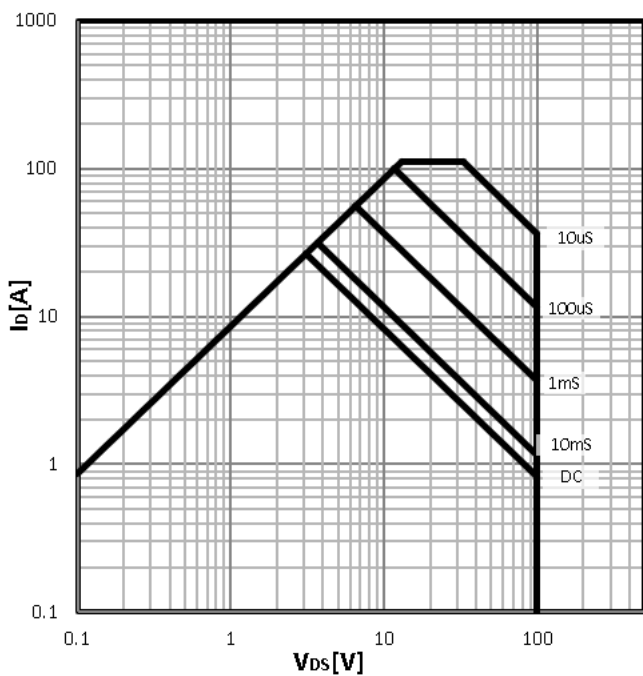
Power Dissipation
 $P_{tot}=f(T_c)$



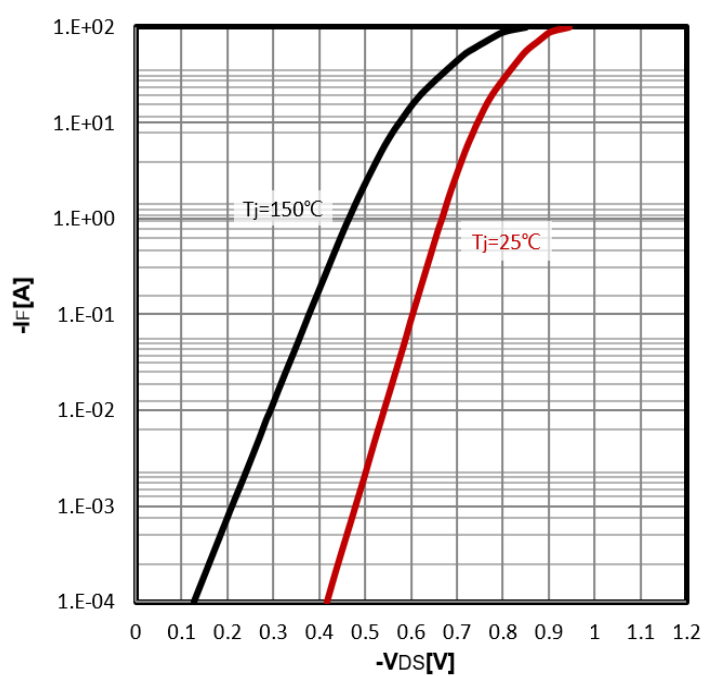
Maximum Drain Current
 $-I_D=f(T_c)$



Safe operating area
 $-I_D=f(-V_{DS})$

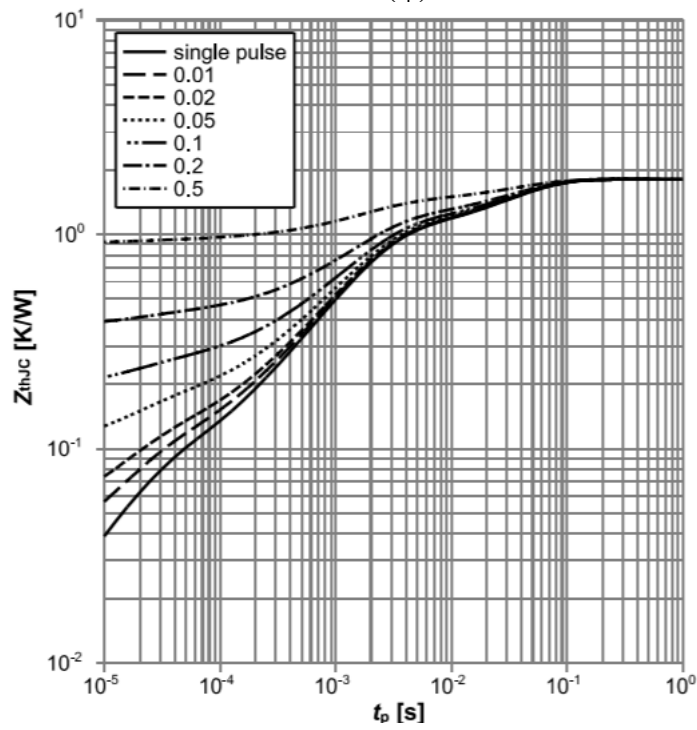


Body Diode Forward Voltage Variation
 $-I_F=f(-V_{DS})$



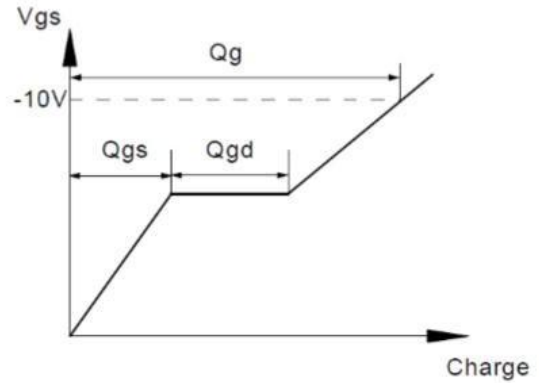
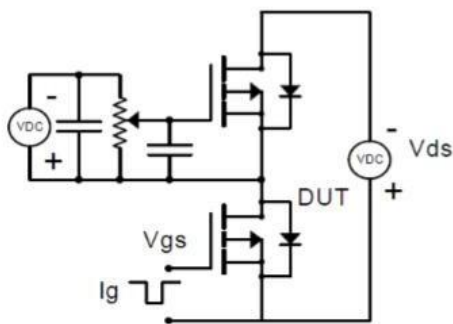
Max. transient thermal impedance

$$Z_{thJC}=f(t_p)$$

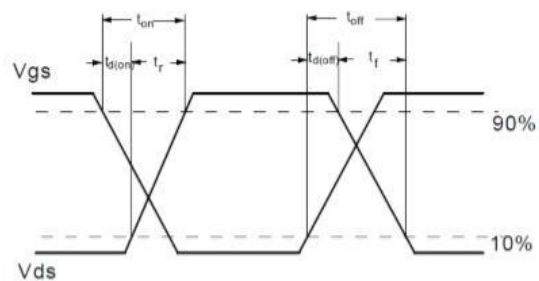
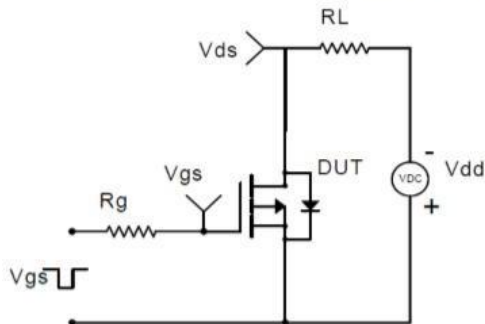


Test Circuit and Waveform:

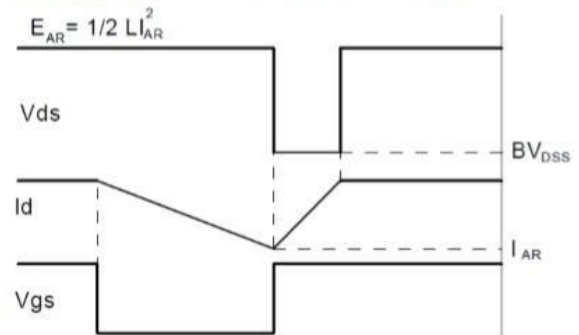
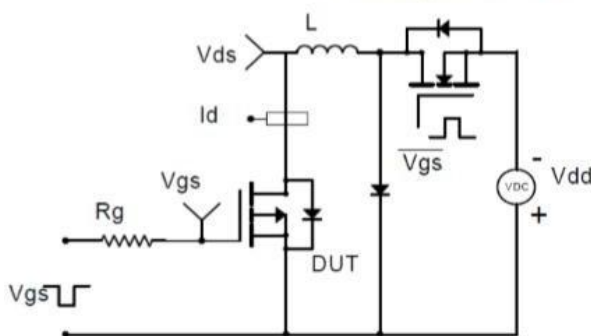
Gate Charge Test Circuit & Waveform



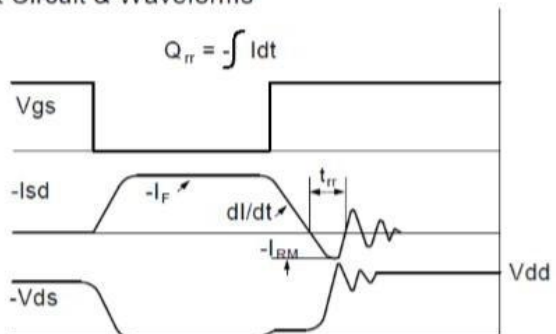
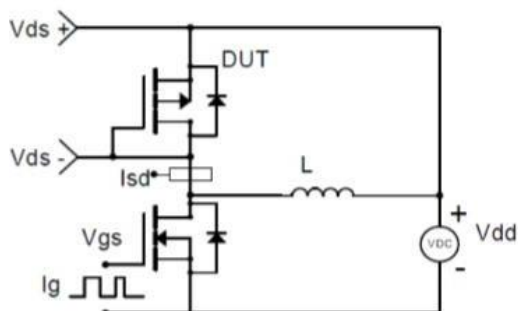
Resistive Switching Test Circuit & Waveforms



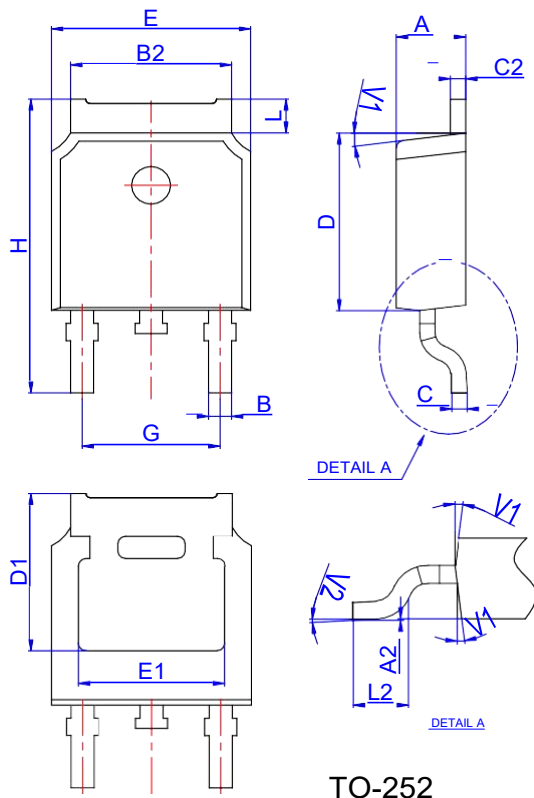
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

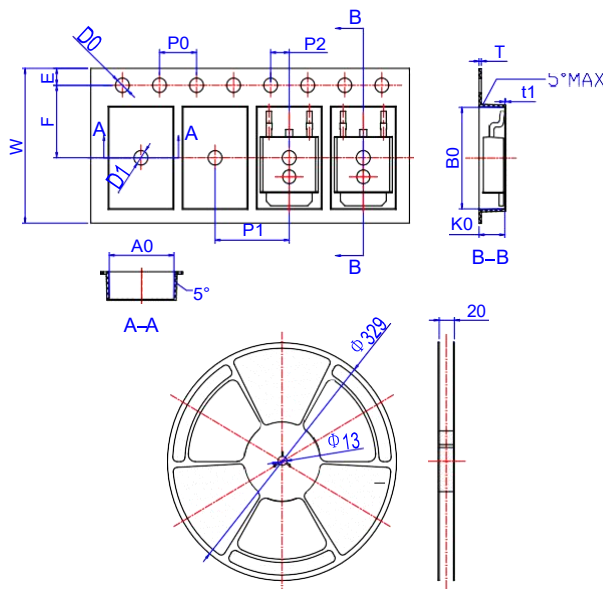


Package Mechanical Data TO-252



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Reel Specification-TO-252-4R



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
B0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
T	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583